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High Concentration Shear Exfoliated Colloidal

Dispersion of Surfactant-Polymer Stabilized

Few-Layer Graphene Sheets

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ABSTRACT

To exploit the remarkable properties of graphene fully, an efficient large-scale production method is required. Sonication assisted liquid phase exfoliation of graphite, for example, has been extensively used for the production of few-layer graphene sheets, but suffers from low efficiency and high energy consumption, and thus is not viable for large scale production. Here we demonstrate a method that is more efficient and has higher scalability potential than sonication. We show that a few-layer graphene at high concentration of up to 1.1 mg ml⁻¹ can be achieved in aqueous based medium by highly efficient shear exfoliation of graphite in a processing time of just 2 h. The exfoliation process was carried out in a commercially available high shear colloidal mixer fixed with a three stage rotor-stator shear generator for optimum exfoliation with a continuous circulation system. The high efficiency and significant improvement over sonication adopting our method was demonstrated by the fact that the conversion to few-layer graphene sheets produced after just 30 min by shear exfoliation required, in contrast, hundreds of hours by sonication. High concentration defect-free few-layer graphene in aqueous medium, produced at short shearing time, demonstrates that this method has high potential for large-scale production. The produced graphene films exhibit additionally a high electrical conductivity of about 29 000 S m⁻¹.

Keywords: graphene; mechanical exfoliation; shear exfoliation; liquid phase exfoliation; surfactant stabilization; polymer stabilization

1. INTRODUCTION

Graphene is a 2-dimensional material, defined by planar sp² hybridized carbon atoms, which are arranged in a honey-comb lattice, and has become one of the most studied laminar materials in the last decade or so due to its extraordinary properties. Graphene can be considered as a building block of carbon allotropes; it can be wrapped to form zero-dimension fullerenes, rolled to form one-dimensional carbon nanotubes and stacked to form three-dimensional graphite. The first successful exfoliation of free-standing graphene was achieved by Novoselov et al.[1] in 2004, and this led to the beginning of the so-called graphene revolution that has prompted growing interest from both academia and industry in graphene research. This huge interest is unsurprising considering the material properties exhibited by graphene. Graphene is synonymous with material of superlative functionality. Free-standing single graphene sheets possess an extremely high electron mobility, having values in excess of 200 000 cm² V⁻¹ s⁻¹ at room temperature [2, 3], which is much greater than in semiconductors or metals [4]. Graphene is also one of the strongest materials known, with a Young's modulus of 1 100 GPa (~200 times stronger than steel) and fracture strength of about 125 GPa [5]. Graphene has also a theoretical specific surface area [6] of 2 630 m² g⁻¹, thermal conductivity [7] of 5 000 W m⁻¹ K⁻¹, and excellent gas barrier properties [8]. Due to these properties, graphene has huge potential for application in energy storage devices [9-11], polymer nanocomposites [12-15], sensors [16, 17], solar cells [18], printable electronics [19, 20] and catalysts [21], for example. However, most of these applications require defect-free graphene produced in large quantities.

Several different methods exist for graphene production and each presents its own challenges. Micromechanical cleavage [22] is the popular choice for many, not surprising given that it led to the 'birth' of graphene. Despite the high quality graphene flakes that can be produced by this method, low yield and process expandability still remain the main drawbacks. Graphene grown on metal substrates, via methods such as epitaxial growth or chemical vapor deposition [23-25], involves not only high energy consumption but also requires subsequent transfer of graphene to other target substrates for a variety of applications, thus limiting the general applicability. Chemical reduction of graphite oxide (GO) [26-29] is one of the widely used methods for the production of graphene and has shown high scalability potential. However, such harsh chemical treatment of graphite introduces hydroxyl or epoxide groups in the basal plane and carbonyl and carboxylic moieties on the edges [30], which in turn disrupt the electronic structure of graphene [28], and makes GO essentially a semiconductor. Furthermore, it is impossible to remove all the defects completely by any known method [31]. Therefore, reduced graphene oxide still retains some defects [29].

Direct exfoliation of graphite was first carried out by Coleman *et al.* using the liquid phase exfoliation (LPE) method via sonication of graphite in organic solvents [32]. Polymers [33, 34] and surfactants [35-38] have also been used to enhance the exfoliation process and prevent against re-aggregation of the exfoliated sheets in LPE systems. LPE encompasses mainly two different approaches for exfoliation of graphite; cavitation and shear forces in sonication and high shear mixing, respectively. Compared to other methods, LPE is a simple method with high potential for large scale production of graphene. The basic equipment needed for sonication or shear processing of graphite is generally available, and, besides, LPE does not require high temperature or vacuum

systems. However, large scale application of sonication assisted LPE of graphite has been hindered due to high energy consumption and low concentration of produced graphene. For example, in the work made by Coleman and coworkers [35], they could only manage to produce a graphene dispersion with a concentration of 0.3 mg ml⁻¹ after 400 h of bath sonication. Moreover, particularly, organic solvents [39] that have been shown to aid exfoliation of graphite to graphene under sonication assisted LPE are required at sufficiently high concentrations to be effective, e.g. N-methyl-pyrrolidone (NMP) [32] and N,N-dimethylformamide (DMF) [40] are not only considered toxic but expensive, making them inappropriate for large scale industrial production.

Low energy consumption and easy availability of shear mixers, has meant that shear exfoliation of graphite is increasingly being considered as an alternative to sonication for large scale production of graphene dispersions [41, 42]. Shear mixing is an old technique that has been widely used in colloidal science, mostly for disintegration of agglomerates during dispersion. A few reports have also been shown where shear mixing has been incorporated into delamination of layered materials [43, 44]. However, most of these applications first involve intercalation of 2-dimensional materials with oxidants, sulfate ions *etc.*, which induces swelling of the material followed by shear exfoliation into individual layers. The intercalation step also hinders the potential for large scale graphene production. Recently, it has been shown that shear mixing can be used for direct exfoliation of graphite without any intercalation [41, 45]. However, despite the potential for upscaling, Coleman and coworkers [41] could only manage to produce graphene dispersions with a concentration of up to 0.07 mg ml⁻¹, which is very low and disadvantageous for most applications. It is evident, therefore, that both current sonication and shear-assisted LPE methodologies have limitations when considering them for large scale production of graphene,

with the main drawbacks hindering their development being the low concentration of the resulting graphene dispersion and high energy consumption by sonication and environmentally questionable chemical aid consumption by shear-induced exfoliation.

Here we demonstrate a simple and effective method based on shear-induced exfoliation for the production of high concentrated few-layer graphene dispersions in aqueous solutions of polymer and surfactant. The exfoliation process is achieved using a commercially available high shear colloidal mixer. Exfoliation and stabilization of few-layer graphene is simultaneously achieved using poly(vinyl pyrrolidone) (PVP) and a surfactant, sodium cholate (SC), in aqueous medium. Compared to the commonly used organic solvents, aqueous based media for graphene dispersions are not only low cost but also eco-friendly, thus making them a viable option for sustainable large scale production. PVP is a non-ionic and biocompatible macromolecule that is highly soluble in water and has a strong affinity to graphene/graphite surfaces, and contains an N-substituted pyrrolidone ring structure that resembles that of NMP solvent, which explains in part why it should be considered an effective substitute for NMP [32] as an exfoliant of graphene as it has already been utilized to stabilize carbon nanotubes [46]. SC is already a well-known bile salt anionic surfactant that has also been widely used for carbon nanotubes stabilization [47-49]. In this study, we also show that high concentration graphene dispersions can be achieved at much shorter times using high shear colloidal mixing, proving that this method can be used for large scale industrial production of few-layer graphene sheets. By using scanning electron microscopy (SEM), atomic force microscopy (AFM) and Raman spectroscopy, we show that the shear exfoliated graphene dispersion consisting of few-layer graphene sheets is essentially free from defects.

2. EXPERIMENTAL

2.1. Materials

Graphite natural flakes with particle size +100 mesh (> 75 %) Product Number: 332461, poly(vinyl pyrrolidone) (PVP) (M_W : 10 000 g mol⁻¹), and sodium cholate (SC) were purchased from Sigma Aldrich and used without any modification. Distilled water was used throughout the experiments.

2.2. Preparation of graphene dispersions

Shear exfoliation was performed using an IKA Magic Lab (1-1 Module MICRO-PLANT equipped with a single walled open 1 l vessel) high shear mixing equipment with a maximum flow rate of 80 1 h⁻¹ shown in Figure 1. All experiments were conducted at a rotation speed of 20 000 min⁻¹ (rpm) for the predetermined time. The equipment was equipped with a three stage rotor-stator shear generator system, Coarse-Medium-Fine arranged in series for optimum performance. Graphite natural flakes were dispersed in aqueous solutions at a concentration of 40 mg ml⁻¹ for all experiments. High concentration of starting graphite was used to maximize resulting graphene concentration. Aqueous solutions of polymer and surfactant were made by dissolving PVP and SC in distilled water, respectively, at predetermined concentrations, covering the ranges: PVP concentration 1, 5, 15, 20 mg ml⁻¹ and SC 0.4, 1, 2, 3 mg ml⁻¹. The IKA Magic Lab was cooled with cold running water during the whole duration of the experiments to keep the dispersion temperature around room temperature. A starting graphite dispersion of 500 ml was prepared for all experiments. About 100 ml of graphene dispersions were collected after 15, 30, 60, 90 and 120 min of shear-induced exfoliation. The dispersions were kept overnight to allow the bigger particles to settle down and then centrifuged for 60 min at a rotation speed of 4 700 rpm in a Thermo

Scientific centrifuge SL40FR to remove all unexfoliated graphite flakes. The supernatant was carefully collected and used for further analysis.

2.3. Equipment and techniques

2.3.1. Vacuum filtration

To calculate the concentration of graphene, a known volume of graphene dispersion was filtered on a filter paper with a pore size of 20 nm. The mass of the filter paper was measured before and after filtration after drying in a vacuum at 40 °C for 24 h. The filtered films were also used for Raman and SEM analyses.

2.3.2. UV-Vis spectroscopy

To correlate the concentration of graphene and extinction in graphene dispersion using the Lambert-Beer law, UV-Vis measurements were carried out using a Shimadzu UV-Vis spectrophotometer 2550 at wavelengths 200 – 800 nm. The dispersions were controllably diluted before the measurements. The extinction of graphene dispersed in PVP and SC was measured at the wavelength of 660 nm at which the effects of PVP and SC are negligible.

2.3.3. Atomic force microscopy (AFM)

AFM images were recorded with a Multimode 8 atomic force microscope equipped with a NanoScope V controller (Bruker Corporation, Billerica, MA), operating in tapping mode on Si substrates. Samples for AFM images were prepared by drop-casting a high diluted dispersion on Si wafers and left to dry in ambient conditions. The wafers were further dried in a vacuum oven at 60 °C for 24 h. Before deposition, the Si wafers were bath sonicated in distilled water for 10 min

and subsequently dried with nitrogen. This was then followed by UV radiation treatment for 30 min.

2.3.4. Raman spectroscopy

Raman spectra were measured using a WITec alpha300 R Raman microscope (alpha 300, WITec, Ulm, Germany) equipped with a piezoelectric scanner using a 532 nm linear polarized excitation laser. The vacuum filtered films prepared from graphene dispersions were used for Raman analysis.

2.3.5. Scanning electron microscopy (SEM)

The structure of the filtered films was recorded using a Zeiss Sigma VP scanning electron microscope at 1-2 kV acceleration voltage. The films were first sputtered with a \sim 4 nm platinum film.

2.3.6. Particle sizing

The ensemble average hydrodynamic equivalent spherical diameter of graphene sheets in the dispersion was measured using Malvern Zetasizer Nano-ZS90 based on the dynamic light scattering (photon correlation) technique.

2.3.7. Electrical conductivity

Electrical conductivity was measured with a four-point probe method (Jandel RM3000: Jandel Engineering Ltd.). The measured resistance was converted to sheet resistance, R_s Ω sq.⁻¹. The specific resistance, ρ , was then calculated from $\rho = R_s \times t$, where t is the film thickness in cm, such that the corresponding electrical conductivity, $\sigma = 1/\rho$ (S cm⁻¹). The electrical conductivity was also measured after annealing the films at 400 °C in nitrogen atmosphere for 2 h.

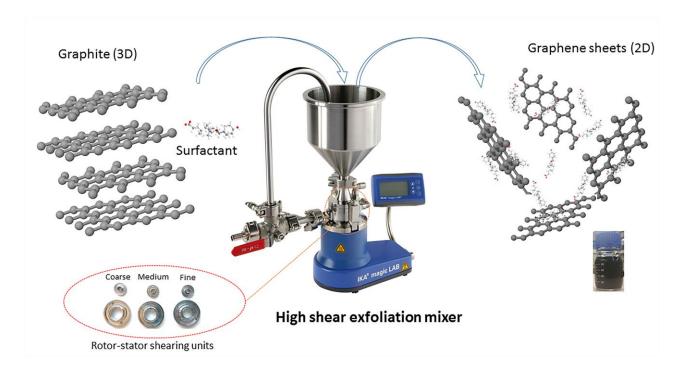


Figure 1. Schematic illustration of the exfoliation process using a high shear colloidal mixer. The starting graphite was first added to PVP or SC solution and subjected to high shear mixing. The resulting mixture was then centrifuged to remove unexfoliated graphite.

3. RESULTS AND DISCUSSION

The concentration of graphene (C_G) in the dispersions was determined using the UV-Vis spectroscopy. The optical absorbance is directly proportional to concentration according to the Lambert-Beer extinction law, $Ext = \varepsilon C_G l$, where Ext is the extinction, ε is the extinction coefficient, C_G is the concentration and l is the path length. The extinction coefficient is the sum of absorbance (α) and scattering (σ_{scatt}) coefficients, such that $\varepsilon(\lambda) = \alpha(\lambda) + \sigma_{scatt}$ (λ) [50]. In order to determine the extinction coefficients for SC, α_{SC} , and PVP, α_{PVP} stabilized graphene dispersions, respectively, a large volume of the sample dispersions was first prepared. 500 ml samples of SC and PVP solutions were separately prepared at concentrations of 0.4 mg ml⁻¹ and 1 mg ml⁻¹, respectively.

Powder natural graphite flakes were mixed into each solution (2 mg ml⁻¹) and subjected to shear-induced exfoliation in an IKA Magic Lab for 60 min at 20 000 min⁻¹ (rpm). The resulting particulate dispersion was then centrifuged at 4 700 min⁻¹ for 60 min to remove unexfoliated graphite flakes. The resulting stable and homogenous supernatant was used to determine the extinction coefficients of SC- and PVP-graphene dispersions. The concentrations of SC and PVP were chosen as low as possible to minimize the effect of adsorbed polymer and surfactant on the final graphene concentration.

The extinction of an extracted sample of each system was measured at 660 nm in a cell having a defined path length geometry of 10 mm. A known volume of dispersion was then vacuum filtered on an alumina membrane of known mass. The resulting filter residue film was repeatedly washed with about 3 000 ml of water to remove excess polymer or surfactant followed by vacuum drying overnight. The graphene solids concentration, C_G , was thus determined using a high precision microbalance, assuming that any irreversibly adsorbed polymer or surfactant on the graphene surface contributed negligibly to the sample weight. The TGA analysis (not shown) showed that the filtered films contained about 12 % of residual surfactant. This was then taken into account for the final calculation of graphene concentration and determination of extinction coefficient.

The extinction coefficients were determined using the calibration curves for SC and PVP stabilized systems shown in Figure 2A. It is clear from Figure 2A that both SC and PVP stabilized graphene dispersions obey the Lambert–Beer law as evidenced by the linear relationship between extinction and concentration. The calculated mean values of α for the SC and PVP stabilized systems were α_{SC} = 3 236 and α_{PVP} = 1 893 ml mg-¹ m⁻¹, respectively. These values were then used to calculate the concentration of graphene in all subsequent colloidal dispersions.

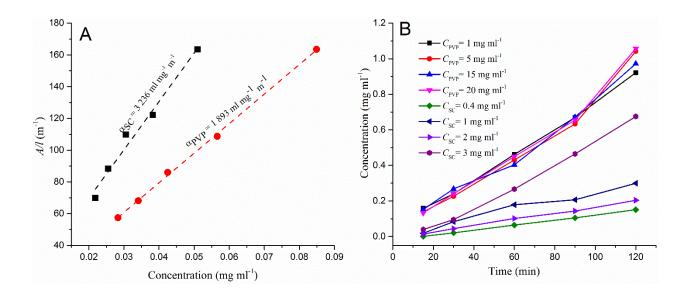


Figure 2. (A) Optical extinction (660 nm) per unit length as a function of graphene dispersion concentration for PVP and SC systems. A Lambert-Beer behavior is shown, with an extinction coefficient α_{SC} and α_{PVP} of 3 236 and 1 893 ml mg⁻¹ m⁻¹, respectively. (B) The final concentration of few-layer graphene as a function of shearing time for different initial concentration of PVP and SC. The concentration of graphene increases with an increase in shear processing time for both SC and PVP. Higher initial SC concentration leads to a higher graphene yield, but the yield remains constant with an increase of PVP concentration.

In sonication-assisted LPE, the concentration of graphene increases with sonication time [51]. We here also investigated the effect of shearing time on the concentration of graphene. A volume of 500 ml of graphite dispersion for SC and PVP systems was prepared and subjected to shear exfoliation. Aliquots of 100 ml were collected after 15, 30, 60, 90 and 120 min, centrifuged and subjected to UV-Vis absorbance measurements. Figure 2B shows that graphene concentration increases with shearing time. The maximum concentration of graphene after 120 min for the PVP system was ~1.1 mg ml⁻¹ whilst ~0.7 mg ml⁻¹ for SC system. These values are much higher than

those reported for sonication exfoliation. For example, 0.3 mg ml⁻¹ after 430 h of sonication [35], 0.09 mg ml⁻¹ after 1 h of tip sonication [52] for SC systems, whilst 0.42 mg ml⁻¹ and 0.1 mg ml⁻¹ after 6 h of bath sonication for PVP systems [33, 34] and 1.2 mg ml⁻¹ in NMP after 270 h of bath sonication [51].

We also studied the dependence of graphene concentration on the initial concentration of PVP and SC as shown in Figure 2B. For the PVP system, the initial concentration has little effect on the final concentration of graphene. These findings slightly differ from the study of Wajid et al. [33] where they found graphene concentration, $C_{\rm G}$, to be dependent on PVP concentration up to 10 mg ml⁻¹, but, beyond that, C_G remained constant despite increasing PVP concentration further. However, for SC systems, there is a strong dependence of C_G on initially added SC concentration. C_G increased significantly with an increase in the initial SC concentration. In this context it is important to note that the stabilization mechanisms of graphene in dispersions for PVP and SC are different. For PVP systems, steric repulsion plays a major role [53]. On the one hand, the PVP used in this study with M_w : 10 000 g mol⁻¹ has long chain molecules with lengths greater than the attraction range of the van der Waals force. Therefore, when PVP is adsorbed onto the surface of graphene sheets, it forms a coating with several tails extending from the surface that creates a repulsive force between graphene sheets, and the long molecule chains also prevent the particles from getting close enough to each other for the van der Waals force to be effective. This prevents re-aggregation of graphene sheets and thus supports a stable dispersion. On the other hand, graphene stabilization in SC systems is achieved via the electrostatic charge effect [37], i.e. the charged SC molecules adsorb onto the surface of graphene leading to the formation of an electrical double layer and the resulting Coulomb repulsion that prevents aggregation of graphene sheets.

The Hildebrand solubility parameters have been used to determine suitable solvents for graphene dispersions. It has been shown that the good dispersion media for graphene is characterized by a Hildebrand solubility parameter of $\delta_T \sim 23$ MPa^{1/2}, and Hansen solubility parameters of $\delta_D \sim 18$ MPa^{1/2}, $\delta_P \sim 9.3$ MPa^{1/2} and $\delta_H \sim 7.7$ MPa^{1/2} [54]. These criteria are very useful when finding solvents for forming suitable dispersions of graphene. However, application of the Hildebrand solubility parameter has some limitations. For instance, the Hildebrand solubility parameter is most suitable for nonpolar and systems without hydrogen bonding and it is used predominantly for polymer solutes, however, graphene is distinctive in its interaction with various solvents [55]. Therefore, the Hildebrand solubility parameters in relation to graphene, dispersed in polymer and surfactants polar systems that are used in this study are not discussed further.

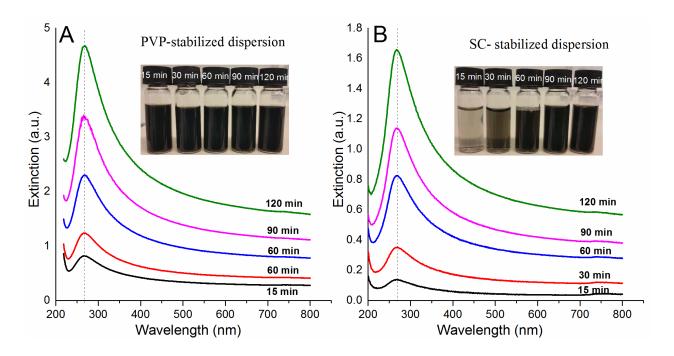


Figure 3. UV-Vis extinction spectra of graphene dispersion at different shear times for (A) PVP system ($C_{PVP}=1 \text{ mg ml}^{-1}$), (B) SC system ($C_{SC}=0.4 \text{ mg ml}^{-1}$) with the inserts showing the optical changes in relation to shearing time

In all the cases in this paper, graphene concentration was measured only after centrifugation. Even as a function of shearing time, the samples were first centrifuged before analysis. Besides determining the graphene concentration in these separated centrifuged samples, UV-Vis spectroscopy can also be used to show evidence of exfoliation of graphite in the complete dispersion as shearing proceeds. The UV-Vis extinction spectra are shown in Figure 3A and Figure 3B for PVP and SC systems, respectively, at different shearing times. Quasi two-dimensional materials have a distinct UV-Vis spectrum that makes it easy to show evidence of successful exfoliation of graphite to graphene in dispersions. As expected, the spectra for both systems are featureless and flat in the visible region with a maximum absorption observed at around 270 nm. This behavior is similar to what was reported by Lotya et al. [37] and Longxiu et al. [40]. Different shearing times show different levels of absorbance, and the highest absorbance corresponds to the longest shearing time. The maximum absorption peak at ~270 nm is attributed to the $\pi \to \pi^*$ transitions of aromatic C–C bonds in graphene [56]. It is also important to note that the spectral positioning of the peak is similar to that seen from highly reduced graphene oxide that normally starts at ~231 nm for unreduced graphene oxide and red-shifts by ~40 nm to ~270 nm after complete reduction [57]. Therefore, the positioning of the absorption peak and the overall high absorption values observed between 270-800 nm strongly suggest the presence of two-dimensional material in the dispersion [58, 59], thus confirming the successful exfoliation of graphite to graphene by high shear mixing. These attributes are present in all the aliquots taken from our process starting at 15 min. This shows that graphene is already produced even at that short shearing time. The concentration at that time is of course low, namely just below 0.1 mg ml⁻¹ for SC and 0.2 mg ml⁻¹ for PVP systems, as was shown earlier in Figure 2B. However, it is importantly the

case that, when compared to other reported values after sonication for many hours these values even at 15 min are significantly higher.

Additionally, as the shearing time increases so does the concentration of dispersed graphene sheets in the dispersion and also this helps to break down thick graphene stacks into individual layers, thus increasing the final concentration of separated graphene sheets. This is indicated by the increasing peak intensities at 270 nm with shearing time as depicted in Figure 3A and Figure 3B, with the inserts showing the optical changes of dispersion with increasing shearing time. The optical density is dependent on the concentration of graphene dispersions. As the shearing time is increased, the number of graphene particles in the dispersion increases, and thus the absorbance and scattering are depicted by a continuous increase of extinction as a function of shearing time in Figure 3. That the maximum of the peak increases in relation to the remaining spectrum faster the longer the shearing time, we can conclude that the process is efficient throughout, in that the separation of the layers runs according to the power law expected, i.e. the graphite stacks disintegrate into finer stacks, which, in turn, then continue to delaminate and finally exfoliate into few-layer graphene, such that the remaining graphite concentration declines as a negative power law. Visual observation of the inserts in Figure 3 confirms the earlier investigation in Figure 2B, in that few-layer graphene in the PVP-containing aqueous medium is more concentrated than in the SC-containing. The inserts in Figure 3 also show that the produced dispersions are homogeneous and stable without any visible sedimentation even after a few weeks.

In comparison to similar methods for mechanical exfoliation of graphene that have been reported in the literature, as shown in Figure 4 and Table 1, it is clear that the method that has been utilized

in this work is able to produce high concentrations of graphene dispersions more efficiently. These other methods require hundreds of hours of processing to reach similar concentrations, and thus are not considered viable for large-scale industrial application.

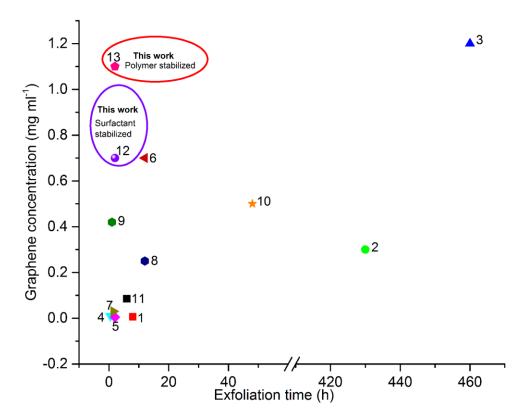


Figure 4 Comparison of this work with reported literature data for the concentration of mechanically exfoliated graphene as a function of processing/exfoliating time^a.

Table 1 Comparison of literature data with this work for the concentration of mechanically produced graphene in relation to exfoliation time and stabilizers

No. on	Method	Exfoliation medium	Time ^a ,	Concentration,	Ref.
graph			h	mg ml ⁻¹	
1	Sonication	ortho-dichlorobenzene	8	0.0065	[60]
		(o-DCB)			
2	Bath	Water-sodium cholate	430	0.3	[35]
	sonication	solution			
3	Sonication	<i>N</i> -methyl-pyrrolidone	460	1.2	[51]
		(NMP)			
4	Bath	<i>N</i> -methyl-pyrrolidone	0.5	0.01	[32]
	sonication				
5	Shear	<i>N</i> -methyl-pyrrolidone	2	0.0045	[41]
	exfoliation				
6	Sonication	Water -Triton X-100	12	0.7	[61]
		solution			
7	Shear and	ortho-dichlorobenzene	1.5	0.03	[62]
	sonication				
8	Sonication	Water-Sodium cholate	12	0.25	[63]
9	Tip	Polyvinylpyrrolidone	1	0.42	[33]
	sonication	solution			
10	sonication	Low boiling point	48	0.5	[64]
		solvents			
11	Ultrasonic	N-methyl-pyrrolidone	6	0.085	[65]
	bath	(NMP)			
12	Shear	Water-sodium cholate	2	1.1	This work
	exfoliation	solution			
13	Shear	polyvinylpyrrolidone	2	0.7	This work
	exfoliation				

Evidence of exfoliation can also be provided by Raman spectroscopy. Raman spectroscopy is one of the most useful nondestructive methods for characterization of carbon based materials. Raman spectroscopy makes it possible not only to estimate the thickness of graphene sheets [52, 66] but also the quality of deposited graphene layers [51, 62]. Raman spectra were collected on vacuum filtered films that were thoroughly washed with distilled water to remove free PVP and SC. Several measurements were conducted on each single film followed by averaging and normalizing to the G-band intensity. Raman spectra of graphite as a reference together with PVP and SC stabilized few-layer graphene are shown in Figure 5. It is clearly evident that all the typical Raman spectra of graphitic materials are present: the D-band (~1 582 cm⁻¹), G-band (~1 350 cm⁻¹) and 2D-band (~2 700 cm⁻¹) [66]. The G and 2D band are prominent graphene bands and are always present while the presence of the D band depends on the quality of graphene. The D band, also known as the defect band, is due to the breathing mode of the sp² carbon atoms and is only activated in the presence of disorder in the graphene structure. The intensity of the D band increases with the defect level of the material. The G band appears as a result of first order scattering of an E2g mode of graphene and is related to the in-plane vibration mode of sp² bonded carbon atoms. The 2D band is the second order two phonon process of the D band and does not require defects to be activated and is always prominent even in the absence of the D band. The deconvolution of the 2D band in Raman spectra of SC and PVP stabilized graphene, shown in the Figure 5B, revealed that fewlayer graphene sheets of less than five layers were formed.

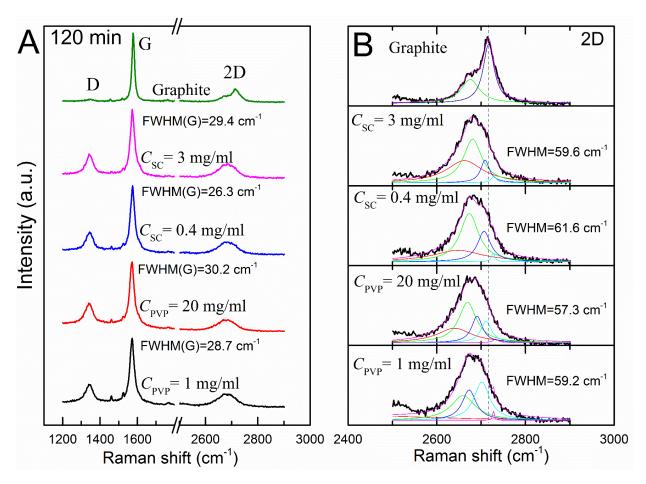


Figure 5. (A) Raman spectra at 532 nm for graphite powder and PVP and SC exfoliated graphene for 120 min shearing at different additive concentrations. The spectra are normalized to the G-band intensity. The graphite spectrum is shown as reference and compared to the SC and PVP stabilized graphene sheets at different concentrations. The D band intensity is seen to increase showing that some defects are induced in the structure by shearing. (B) Corresponding magnified 2D-bands showing 2D band maximum shift for PVP and SC stabilized graphene dispersions. The maximum shift is attributed to the reduction of graphene layers. The shape and maximum shift of the 2D band are consistent with few-layer graphene sheets and the Lorentz peak fitting of the 2D peak corresponds to few-layer graphene flakes.

The shape of the 2D band can be used to identify the number of graphene layers [66, 67]. For fewlayer graphene sheets, the shape of this band is considerably different from that of graphite, as shown in Figure 5B. None of the samples measured for both SC and PVP stabilized few-layer graphene showed graphite-like character, but rather were consistent with few-layer graphene sheets similar to that which was observed by Hernandez et al. [32]. The 2D band in the spectra is also broader than what is expected from single graphene sheets [52], suggesting that the dispersions consists of few-layer graphene. It has also been shown that the 2D maximum shifts to the lower value as the number of layers is reduced [66]. This behavior is clearly evident in Figure 5B for both SC and PVP systems. The 2D band in the spectra for SC and PVP stabilized graphene displayed characteristics that are typical of few-layer graphene sheets of not more than 5 layers [66, 68]. It is important to note that the difference of the 2D band in the spectra for graphite and few-layer graphene for filtered films indicates that even though aggregation occurs during filtration, the aggregation is not the same stacking Bernal AB type as in graphite, but rather random stacking of graphene sheets as shown by the SEM image in Figure 6. Therefore, the randomly stacked few-layer graphene sheets maintain the same electronic structure as in freestanding exfoliated sheets, and this is evident in the Raman spectra of the filtered films.

For single layer graphene, the Raman 2D band is symmetrical and is fitted with only one Lorentzian peak which shows one π electron valence band and π^* conduction band structure that means that one Raman scattering cycle is excited at the **K** and **K'** points. The full width at half-maximum (FWHM) of the 2D band is found to be a quantitative guide to distinguish the number of graphene layers of up to five layers. The FWHM (2D) for single graphene sheets is ~30 cm⁻¹. The FWHM of graphene increases with an increase in the number of layers. In few-layer graphene,

due to the π electron interaction under AB stacking, the electronic bands split into dispersive configurations [69] and, therefore, the more resonant phonons with different frequencies contribute to the widening and lower intensity of the 2D bands. The average FWHM for the 2D band for both PVP and SC stabilized graphene was found to be 59.23 cm⁻¹ (see Figure 5), which is the range for few-layer graphene sheets. These values are consistent with that which has been reported for few-layer graphene sheets in the range between 50-66 cm⁻¹ [66, 70]. The calculated FWHM (G) for graphite from the Raman spectrum is 16 cm⁻¹. This value does not change for defect-free single layer graphene. However, a noticeable increase to an average of 30 cm⁻¹ is observed in our samples for both SC and PVP stabilized graphene. This increase in the FWHM (G) is caused by the sample edges. This is true because the position of the G peak did not shift, which would be the case if the widening is caused by the structural basal plane defects [71, 72].

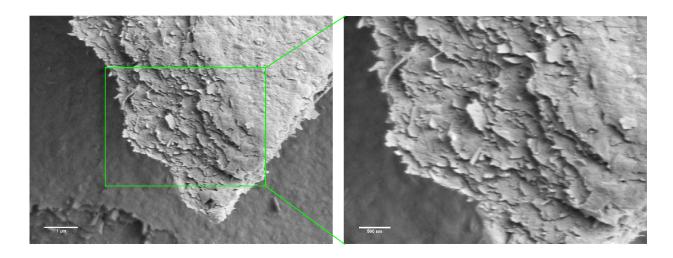


Figure 6. SEM image of vacuum filtered graphene film showing randomly stacked various sizes of graphene sheets. Even though re-aggregation of graphene sheets takes place, it is a random restacking of the sheets rather than the Bernal AB stacking like in graphite. Therefore, Raman

analysis on the surface of the films is able to distinguish between graphite and exfoliated few layer graphene sheets.

The quality of exfoliated graphene sheets can be determined by Raman analysis. As already stated, the intensity of the D band is related to the defects content and these defects can either be topological or the edges of graphene sheets [73]. It is worth noting that the starting natural graphite flakes display a small amount of defect content shown by the slightly visible D band intensity (Figure 5A). The quantity/content of defects can be identified by the intensity ratio of the D band and G band, I_D/I_G (Figure 7). We investigated the effect of shearing time after 60 and 120 min on the amount of defects induced for SC and PVP systems for different concentrations, as shown in Figure 7. The intensity of the D band from graphite gradually increases with shearing time for both SC and PVP systems, indicating that shear exfoliation induces some defects into the graphene sheets (Figure 5). However, we did not find any correlation between initial concentration of SC and PVP and the amount of defects induced. It is also important to know the type of defects induced whether they are basal plane defects or edge defects. Basal planes defects usually result in a broadening of the G band, and the intensity of the D band is generally higher than the G band, as is usually the case for graphene oxide or reduced graphene oxide [28]. The D band for both SC and PVP systems at 60 and 120 min shearing time (Figure 5) is both narrow and less intense than the reported values for graphene oxide, and, besides, the typical broadening of the G band is also not observed. This indicates that the defects induced by shear exfoliation are not basal plane defects.

However, the introduction of the edge defects is inevitable because the size of the flakes is reduced by shearing and the total edge length increases with the reduction of flake sizes. This was confirmed by the light scattering measurements in Figure 8A, which show that the sizes of graphene flakes are reduced with shearing time, and thus total edge length increases with the reduction of flake size. Moreover, the spot size of the spectral laser illumination, 1-2 µm, suggests that the Raman beam will always cover a large quantity of graphene sheet edges in the filtered film, since the average flake size is much smaller than the laser spot size. The small intensity of the D band and lack of broadening of the G band, as in the case of graphene oxide, is compelling evidence that the defects induced in the graphene sheets are attributable to the edge defects rather than basal plane defects. Also, the intensity ratio of I_D/I_G for both our systems is in the range of 0.1 - 0.3, significantly lower than that reported for graphene oxide with basal plane defects (>1) [28] and for sonication dispersed graphene (\sim 0.6) [36, 51]. This study for defect quantification by Raman analysis is thus in agreement with reported analyses [37, 41, 51, 66]. These values, therefore, confirm that the high shear mechanism for exfoliation of graphite used in this study produces high quality few-layer graphene sheets free from basal plane defects.

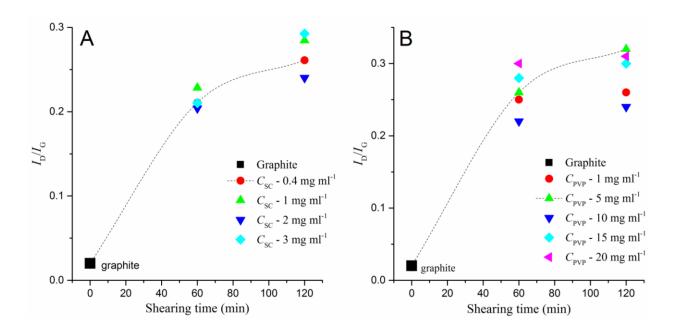


Figure 7. Quantification of defects level by intensity ratio of I_D/I_G as a function of shearing time for (A) SC system and (B) PVP system. The I_D/I_G intensity ratio increases with shearing time as more edges are introduced due to the reduction of flake sizes during shear exfoliation, and thus, some grinding. The initial concentration of SC and PVP have no apparent effect on the amount of defects induced by shear exfoliation.

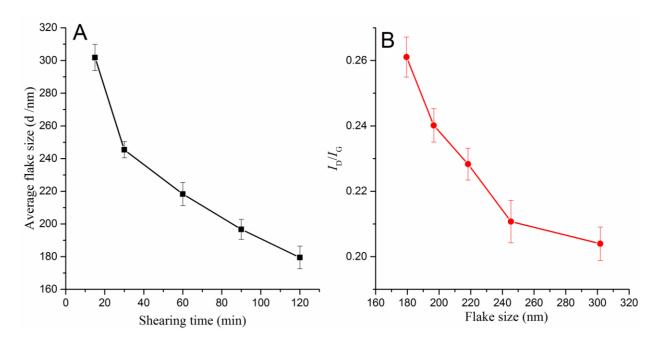


Figure 8. (A) Average flake size as function of shearing time measured by dynamic light scattering. The size of the flakes decreases with an increase in shearing time. (B) The dependence of I_D/I_G ratio on graphene flake size. The defect content increases with the reduction of flake size because more edges are introduced with the reduction of flake sizes by shearing.

Evidence of exfoliation can also be provided by showing the thickness of exfoliated graphene sheets. AFM is one of the most implemented methods for quantifying the degree of exfoliation of graphene sheets [74]. Graphene dispersions were deposited on Si/SiO₂ wafers then washed in water to partially remove some of the excess dispersant. It is important to note, that the reaggregation of the graphene sheets occurs when the surfactant or polymer is washed off, therefore the AFM measurement does not necessarily depict the actual state of graphene sheets suspended in the dispersion. When doing statistical calculation, we only considered sheets that clearly showed no signs of re-aggregation for the final quantity count. One other thing to consider is that it is impossible to remove completely all the surfactant or polymer from the graphene sheets, therefore

AFM thickness measurements normally show the apparent thickness rather than the actual real thickness of the deposited graphene sheets [41]. The graphene dispersion was diluted before deposition in an attempt to minimize this effect. A large numbers of flakes with different sizes can be seen from the AFM image of deposited SC stabilized graphene on Si/SiO₂ wafers (Figure 9A). The majority of the observed sheets were few-layer graphene flakes although we also observed aggregates with thickness over 15 nm. Some examples of individual few-layer graphene sheets are shown in Figure 9B and Figure 9C with corresponding height profiles. The majority of the observed flakes were typical of few-layer graphene sheets.

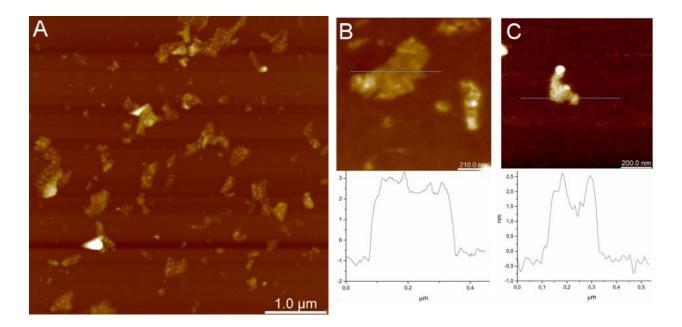


Figure 9. AFM images of SC stabilized graphene sheets on Si wafers. (A) $5 \times 5 \mu m^2$ area showing a large number of graphene sheets with different sizes (B) and (C) magnified images of individual flakes with corresponding height profiles.

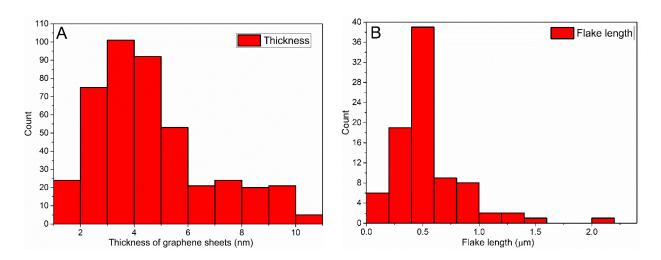


Figure 10. Statistics histogram from AFM image analysis showing (a) the thickness distribution of deposited flakes, and (b) the flake length.

For quantification of the size and thickness of graphene sheets, we measured a large number of deposited flakes, as shown in the histograms in Figure 10. It is clear from the histogram that the majority of exfoliated graphene consists of few-layer graphene sheets of not more than five layers with an average lateral size of $0.5~\mu m$. This confirms that the high shear mixer is able to exfoliate graphite statistically significantly into thin sheets of few-layer graphene.

The electrical conductivity was measured using the four-probe technique from the films prepared by vacuum filtration of the dispersions. The films were dried in a vacuum at 40 °C overnight. The lowest sheet resistance for the SC and PVP stabilized films was about 33 Ω sq.⁻¹ and 383 Ω sq.⁻¹, respectively, as shown in Table 1, corresponding to the electrical conductivity of about 14 600 S m⁻¹ and 710 S m⁻¹ respectively (Figure 11). The highest conductivity was observed for

the films with the lowest initial polymer or surfactant. The presence of residual surfactant or polymer is higher in the films prepared with the highest initial concentrations. This greatly affects the film properties as the trapped polymer or surfactant between the graphene sheets is impossible to remove by simple washing. However, the conductivity of these films, especially for SC stabilized graphene, is much higher than that which was achieved from similar systems 35 S m⁻¹ before annealing and 1 500 S m⁻¹ after annealing at 250 °C for 2 h [37], and 7000 S m⁻¹ before annealing, rising to 17 500 S m⁻¹ after annealing at 500 °C for 2 h. These values are also higher than the films prepared from reduced graphene oxide, which were reported as having conductivities ranging from 7 000 S m⁻¹ to 10 000 S m⁻¹ [29, 57]. After annealing the films at 400 °C for 2 h, a significant decrease of sheet resistance was observed especially for the PVP stabilized samples, with an average 38 Ω sq.⁻¹, equivalent to an electrical conductivity of about 8 000 S m⁻¹ (Figure 12B). However, for the SC stabilized films, the electrical conductivity rose to about 29 000 S m⁻¹ after annealing (Figure 12A).

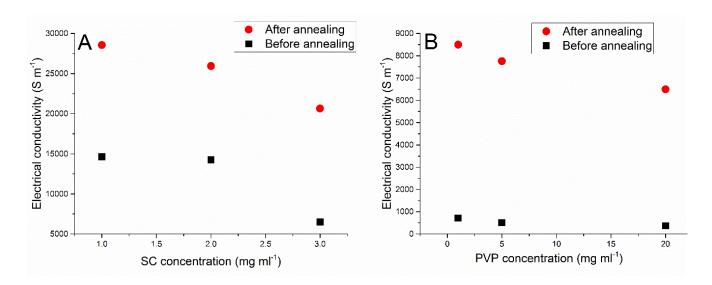


Figure 12. Electrical conductivity as a function of concentration for (a) sodium cholate suspensions (b) PVP suspensions for graphene films before and after annealing

Table 2. The dependence of sheet resistance graphene films on the initial PVP and SC concentration

Stabilizing agent	Concentration,	Sheet resistance, ohm sq. ⁻¹		
	mg ml ⁻¹	Before annealing	After annealing	
	1	33	18	
NaC	2	48	21	
	3	92	34	
	1	383	32	
PVP	5	580	45	
	20	765	36	

This study has shown that shear exfoliation is an effective method for exfoliation of few layer graphene sheets confirming the similar study by Coleman and his group [41]. However, the major drawback of this method is low efficiency and low concentration of produced graphene, which makes it impractical for various applications at industrial scale and also in applications that require a large amount of graphene. In this study however, a high concentration of few-layer graphene was achieved at a short processing time which is much higher than any reported work of the similar systems. Therefore, due to the high efficiency, quality and concentration of the produced few-layer graphene sheets, this method has high potential for large scale application.

CONCLUSIONS

We have reported a highly efficient, facile and feasible method for production of high concentration few-layer graphene dispersions with high scalability potential. We have shown that by using a commercially available high shear colloidal mixer, it is possible to produce high

concentration dispersions of few-layer graphene sheets with solid content of up to 1.1 mg ml⁻¹ after just 120 min of high shear mixing in aqueous based medium. This method is more efficient than sonication in terms of yield and energy consumption. AFM and Raman analyses confirmed that the dispersions contain a large number of few-layer graphene sheets. The high shear mixing process can be easily scaled up to produce few-layer graphene dispersions in large volumes. We also showed that the produced few-layer graphene sheets are of high quality and without having made, or containing, any chemical modifications. These dispersions can be used for applications such as solar cells, energy storage devices, nanocomposites etc. Since a high concentration of defect-free few-layer graphene sheets can be obtained in a short time using eco-friendly material additives, this method has real potential for mass production of few-layer graphene.

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COMPLIANCE WITH ETHICAL STANDARDS

CONFLICT OF INTEREST

The authors declare that they have no conflict of interest.

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